We claim:

1. Apparatus for gas distribution in a semiconductor wafer processing chamber comprising:

a roof fabricated from a silicon-based material;

a recess disposed within said roof;

a gas distribution plate disposed within said recess; and

a plurality of apertures disposed within the roof extending from the gas distribution plate.

- 2. The apparatus of claim 1 wherein the recess is disposed on a top surface of the roof.
- 3. The apparatus of claim 2 wherein a seal circumscribes gas distribution plate.
- 4. The apparatus of claim 2 wherein the roof further comprises a plurality of grooves formed in the recess.
- 5. The apparatus of claim 4 wherein the plurality of apertures disposed within the roof extend from each of said plurality of grooves into a bottom surface of the roof.
- 6. The apparatus of claim 1 wherein the roof is fabricated from silicon carbide.
- 7. The apparatus of claim 1 wherein the gas distribution plate is fabricated from silicon carbide.
- 8. The apparatus of claim 1 wherein the recess is formed on a bottom surface of the roof.

- 9. The apparatus of claim 8 wherein a gas feed channel extends from the top surface of the roof to the recess.
- 10. The apparatus of claim 8 wherein the bottom surface of the roof and the gas distribution plate are covered by a material layer.
- 11. The apparatus of claim 10 wherein the material layer is silicon carbide.
- 12. The apparatus of claim 11 wherein the material layer is deposited by chemical vapor deposition (CVD).
- 13. The apparatus of claim 10 wherein the material layer further comprises a plurality of apertures disposed therein.
- 14. The apparatus of claim 1 wherein the gas distribution plate further comprises a plurality of grooves.
- 15. The apparatus of claim 14 wherein the gas distribution plate further comprises a plurality of apertures disposed in each of said plurality of grooves.
- 16. The apparatus of claim 8 wherein the roof is fabricated from silicon carbide.
- 17. The apparatus of claim 8 wherein the gas distribution plate is fabricated from silicon carbide.
- 18. Apparatus for gas distribution in a semiconductor wafer processing chamber comprising:
 - a roof having a top surface and a bottom surface;
 - a recess disposed within the bottom surface of said roof;
 - a gas distribution plate disposed within said recess; and

a material layer coating disposed upon the bottom surface of the roof and the gas distribution plate.

- 19. The apparatus of claim 18 wherein the material layer coating further comprises a plurality of apertures.
- 20. The apparatus of calm 19 wherein the gas distribution plate further comprises a plurality of apertures.
- 21. The apparatus of claim 20 wherein the apertures of the gas distribution plate coincide with the apertures in the material layer coating.
- 22. The apparatus of claim 18 wherein the material layer coating is formed from silicon carbide.
- 23. The apparatus of claim 18 wherein the material layer is deposited by chemical vapor deposition (CVD).
- 24. The apparatus of claim 18 wherein the roof is fabricated from silicon carbide.
- 25. The apparatus of claim 18 wherein the gas distribution plate is fabricated from silicon carbide.

